

**Search Notes**

Application/Control No.

09/967,242

Examiner

JOHN J. LEE

Applicant(s)/Patent under  
Reexamination

GECK ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	434,404.1 411,415 414.1,410 420	3/23/2009	J.L
455	414.2,433	3/23/2009	J.L
455	452.1,517	3/23/2009	J.L
455	515,516	3/23/2009	J.L
455	67.11,565	3/23/2009	J.L
455	435	3/23/2009	J.L

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
455	434,404.1	3/26/2009	J.L
455	411,415	3/26/2009	J.L
455	414.1,515	3/26/2009	J.L
Interference and Inventor search		3/26/2009	J.L

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/23/2009	J.L